ON Semiconductor

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Power MOSFET

30 V, 106 A, Single N-Channel, SO-8 FL

Features

- Integrated Schottky Diode
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- CPU Power Delivery
- Synchronous Rectification for DC–DC Converters
- Low Side Switching
- Telecom Secondary Side Rectification

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Para	Parameter			Value	Unit
Drain-to-Source Volt	Drain-to-Source Voltage			30	V
Gate-to-Source Voltage			V_{GS}	±20	V
Continuous Drain Current R _{θJA} (Note 1)		$T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	I _D	30 22	Α
Power Dissipation R _{0JA} (Note 1)		T _A = 25°C	P _D	3.13	W
Continuous Drain Current R _{θJA} ≤ 10 sec		$T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	I _D	48 34	Α
Power Dissipation $R_{\theta JA,} t \leq 10 \text{ sec}$	Steady	T _A = 25°C	P _D	7.7	W
Continuous Drain	State	T _A = 25°C	Ι _D	22	Α
Current $R_{\theta JA}$ (Note 2)		T _A = 85°C		16	
Power Dissipation R _{0JA} (Note 2)		T _A = 25°C	P _D	1.7	W
Continuous Drain Current R _{B.IC}		T _C = 25°C	I _D	106	Α
(Note 1)		T _C = 85°C		76	
Power Dissipation R _{θJC} (Note 1)		T _C = 25°C	P _D	38	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	320	Α
Current limited by pac	ckage	$T_A = 25^{\circ}C$	I _{Dmaxpkg}	100	Α
Operating Junction as Temperature	Operating Junction and Storage Temperature			-55 to +150	°C
Source Current (Body	Source Current (Body Diode)			54	Α
Drain to Source dV/dt			dV/dt	6	V/ns
Single Pulse Drain–to–Source Avalanche Energy (V_{DD} = 50 V, V_{GS} = 10 V, I_{L} = 45 A_{pk} , L = 0.1 mH, R_{G} = 25 Ω)			EAS	101	mJ
	Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

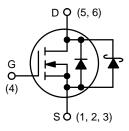


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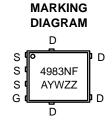
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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	2.1 mΩ @ 10 V	106 A
30 V	3.1 mΩ @ 4.5 V	106 A

N-CHANNEL MOSFET







A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4983NFT1G	SO-8FL (Pb-Free)	1500 / Tape & Reel
NTMFS4983NFT3G	SO-8FL (Pb-Free)	5000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

^{*}For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	3.3	
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	40	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	74	C/VV
Junction-to-Ambient - t ≤ 10 sec	$R_{\theta JA}$	16.3	

- Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size of 100 mm².

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					•		
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 1.0 \text{ mA}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J	I _D = 10 mA, referenced to 25°C			15		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	T _J = 25°C			500	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±20 V				±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	= 1.0 mA	1.2	1.7	2.3	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	I _D = 10 mA, referenced to 25°C			5.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		1.6	2.1	
			I _D = 15 A		1.6		mΩ
		$V_{GS} = 4.5 \text{ V}$	I _D = 30 A		2.5	3.1	
			I _D = 15 A		2.5		
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _D = 15 A			60		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			3250		pF
Output Capacitance	C _{OSS}				1340		
Reverse Transfer Capacitance	C _{RSS}				90		1
Total Gate Charge	$Q_{G(TOT)}$				22.6		
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$			2.9		nC
Gate-to-Source Charge	Q_{GS}				7.0		
Gate-to-Drain Charge	Q_{GD}				6.9		1
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 30 \text{ A}$			47.9		nC
SWITCHING CHARACTERISTICS (Note 4)					_		
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			13.5		ns
Rise Time	t _r				24.9		
Turn-Off Delay Time	t _{d(OFF)}				28.7		
Fall Time	t _f				10.7		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

4. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

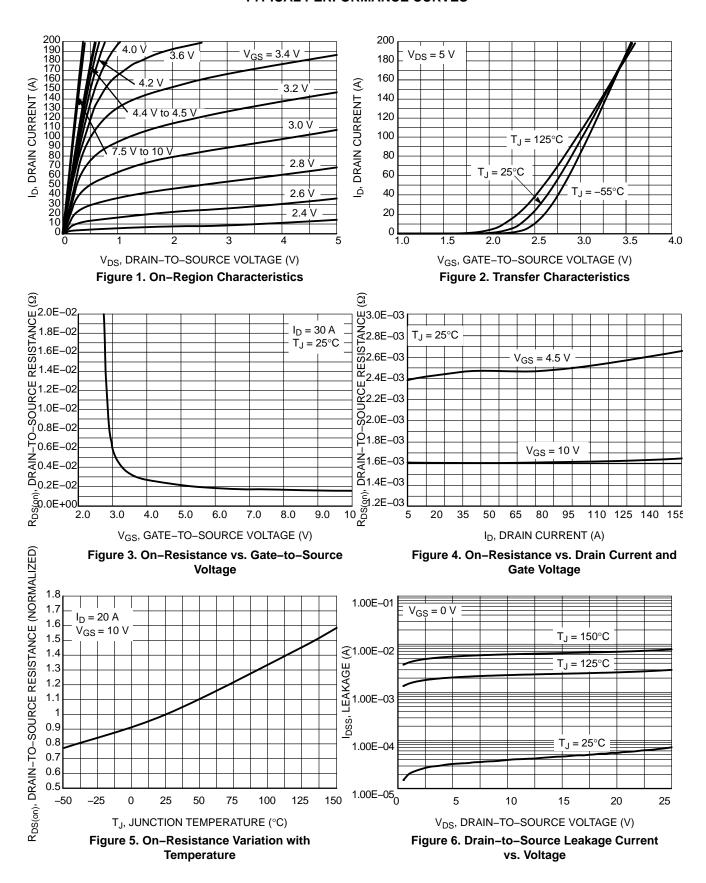
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 4)						
Turn-On Delay Time	t _{d(ON)}			9.4		- ns	
Rise Time	t _r	$V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			16.7		
Turn-Off Delay Time	t _{d(OFF)}				35.2		
Fall Time	t _f				7.4		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V},$ $I_{S} = 2 \text{ A}$ $T_{J} = 25^{\circ}\text{C}$ $T_{J} = 125^{\circ}\text{C}$		0.4	0.7		
			T _J = 125°C		0.32		V
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 2 \text{ A}$			45		ns
Charge Time	t _a				23		
Discharge Time	t _b				22		
Reverse Recovery Charge	Q_{RR}				50		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S	T _A = 25°C			0.65		nΗ
Drain Inductance	L _D				0.20		
Gate Inductance	L _G				1.5		
Gate Resistance	R_{G}				1.0		Ω

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

4. Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES



TYPICAL PERFORMANCE CURVES

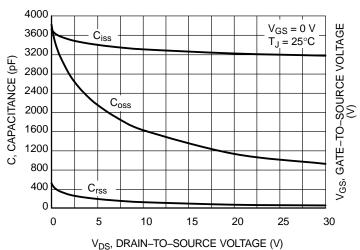
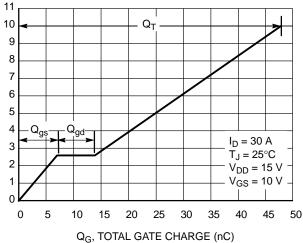


Figure 7. Capacitance Variation



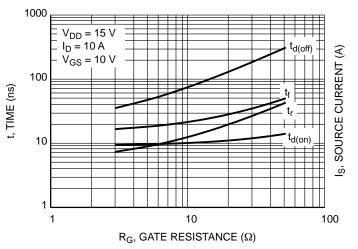


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

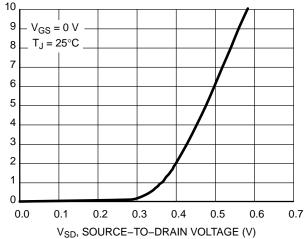


Figure 10. Diode Forward Voltage vs. Current

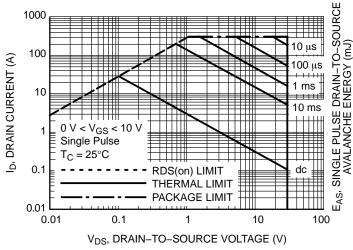
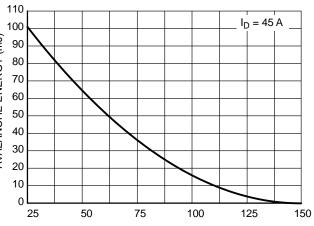


Figure 11. Maximum Rated Forward Biased Safe Operating Area



T_J, STARTING JUNCTION TEMPERATURE (°C) Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL PERFORMANCE CURVES

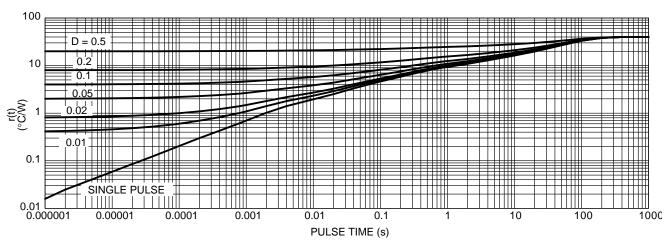


Figure 13. Thermal Response



0.10

0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

DATE 25 JUN 2018

NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETER.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00	-	0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е	1.27 BSC				
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	0.125 REF				
M	3.00	3.40	3.80		
θ	0 °		12 °		

GENERIC MARKING DIAGRAM*



XXXXXX = Specific Device Code

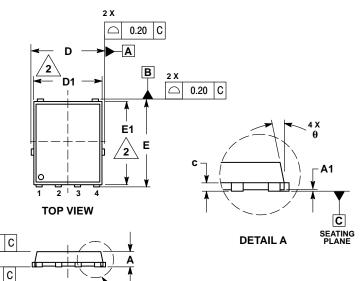
= Assembly Location Α

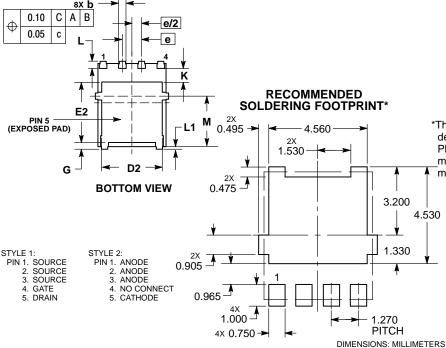
Υ = Year W = Work Week

ZZ

= Lot Traceability *This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■",

may or may not be present. Some products may not follow the Generic Marking.





DETAIL A

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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